


<b>Search Notes</b> 	<b>Application/Control No.</b> 10760012	<b>Applicant(s)/Patent Under Reexamination</b> SUGAHARA ET AL.
	<b>Examiner</b> Shikhman, Max	<b>Art Unit</b> 2609

SEARCHED			
Class	Subclass	Date	Examiner
382	100	2/15/2007	max shikhman
380	54	2/15/2007	max shikhman

SEARCH NOTES		
Search Notes	Date	Examiner
IEEE Xplore, Google Scholar.	2/15/2007	Max Shikhman
USPAT, USPGPUB	2/15/2007	Max Shikhman

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner